

## Publications for H. J. Whitlow b. 31-03-1954

### Doctoral dissertations

1. *Low energy implantation of silicon*. H.J. Whitlow. D. Phil. Thesis. University of Sussex 1980.
2. *Ion-Materials Interactions and their Application*. H.J. Whitlow, D.Sc. thesis, University of Bath 1998.

### Publications in international journals with referee procedure.

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2. Appl. Phys. A29(1982)141. *Short- and long-range ion-beam mixing in Cu:Al, Influence of interfacial oxide*. F. Besenbacher, J. Böttiger, S.K. Nielsen and H.J. Whitlow.
3. Surface Sci. 123(1982)39. *Measurements of angular distributions of sputtered material as a new tool for surface-segregation studies: segregation in CuPt alloys*. H.H. Andersen, V. Chernysh, B. Stenum, T. Sørensen and H.J. Whitlow.
4. Nucl. Instrum. and Method. 209/210(1983)487. *Surface segregation during alloy sputtering and implantation*. H.H. Andersen, B. Stenum, T. Sørensen and H.J. Whitlow.
5. J. Nucl. Material. 115(1983)347. *Lateral stress-induced blistering of aluminium films under helium irradiation*. S.E. Donnelly, M. Renier, A.A. Lucas and H.J. Whitlow.
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